

# Notice of References Cited

Application/Control No.

09/887,296

Applicant(s)/Patent Under Reexam

Chu et al.

Examiner

S. Devi, Ph.D.

Art Unit

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## U.S. PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	US 2002/0064517	05/30/02	Cederholm-Williams	424	93.1
B	US 5,626,837	05/06/97	Shimada et al.	424	49
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## NON-PATENT DOCUMENTS

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages				
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